

TPX3Cam

A fast optical camera for nanosecond photon time stamping



"We use the TPX3Cam for measurements of electrons and ions in our velocity map imaging apparatus. The ns time resolution and data acquisition rate allow us to make measurements in ways that were not possible before. We are very happy with the camera performance."

Thomas Weinacht, Professor at the Department of Physics and Astronomy, Stony brook university, USA

Technology

The TPX3Cam is a fast optical camera for time stamping of optical photons. It is based on a new silicon pixel sensor, which in combination with the and readout, is suitable for a wide range of applications which require time-resolved imaging of electrons, ions or single photons.

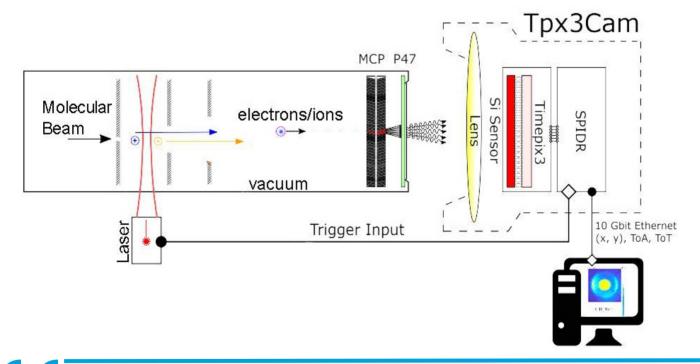
The TPX3Cam can be easily integrated both in tabletop lab setups, as in synchrotron or free-electron-laser environments.

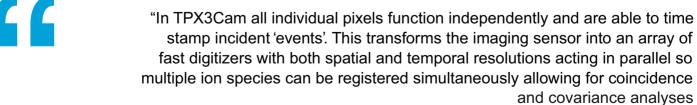
Benefits of TPX3Cam

- Increased light sensitivity silicon sensor
- Wave length range: 400 1000 nm
- Per pixel simultaneous detection of time (ToA) and intensity (ToT)
- Time resolution 1.6 ns, effective frame rate
 > 500 MHz
- Lossless, data driven readout up to 80 Mhits/s
- Flexible optical design outside of vacuum

Image below: TPX3Cam is able to simultaneously image and time-stamp light flashes of more than 1000 photons with high quantum efficiency in the 400 to 1000 nm wavelength range. It can efficiently register ions impinging on a MCP (micro-channel plate) in the VMI (velocity map imaging) configuration. The MCP is coupled to a fast P47 phosphor, which produces light flashes in response to ions hitting the MCP. The TPX3Cam, placed outside of the vacuum, can detect light flashes from the phosphor.

Adapted from Zhao et. al, Review of Scientific Instruments 88, 113104 (2017)





Dr. Andrei Nomerotski Brookhaven National Laboratory, USA

Applications

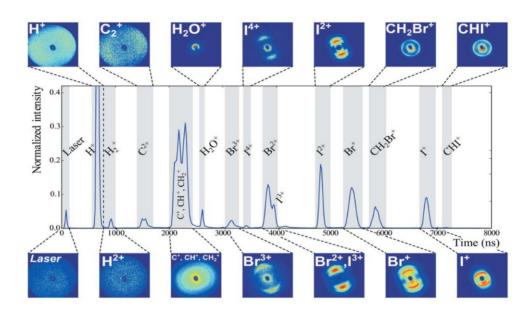
Ion and electron imaging

Applications of TPX3Cam include spatial and velocity map imaging of ions in time-of-flight mass spectroscopy; coincidence imaging of ions and electrons, and other time-resolved types of imaging spectroscopy. TPX3Cam is able to detect and time-stamp ion hits with 1.6 ns timing resolution, thus making it possible to record ion momentum images for all fragment ions simultaneously and avoiding the need to gate the detector on a single fragment.

This single detector design is simple, flexible, and capable of highly differential measurements.

Image below shows ion TOF mass spectrum of CH 2IBr recorded with TimepixCam, a previous model of the TPX3Cam, at the FLASH light source at the German Synchrotron, Hamburg after strong-field ionization with an intense laser pulse along with the camera images for each of the peaks in the TOF spectrum.

Adapted from M.Fisher-Levine et al, J. Synchrotron Rad. (2018) 25, 336-345.



Single photon imaging

The intensified version of TPX3Cam can be single photon sensitive. In this configuration the camera is employed in combination with an off-the-shelf image intensifier. The applications include the wide-field time-correlated single photon counting (TCSPC) imaging, phosphorescent lifetime imaging and any applications requiring time-resolved single photon imaging.

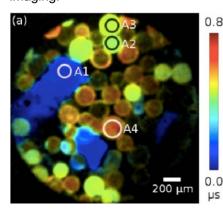


Image (a):
Lifetime images
of beads infused
with different Ir
compounds and
fluorescent plastic
acquired with
TimepixCam, a
previous model of
the TPX3Cam.

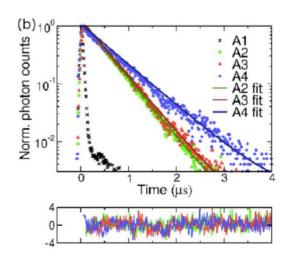


Image (b): Intensity as a function of time (phosphorescence decays) for areas A1-A4 indicated in (a), with monoexponential fits to the phosphorescence decays and residuals of the fits.

Adapted from L. M. Hirvonen et al, Rev. Sci. Instrum. 88, 013104 (2017).

TPX3Cam specifications

Sensor	
Material	silicon with enhanced
	light sensitivity
Wave length range	400 - 1000 nm
Detection limit	~1000 photons per pixel hit
Optics	
Sensor active area	14.1 x 14.1 mm ²
Туре	C-mount
Minimal distance	42 mm
lens to sensor	
Imaging ASIC	
Туре	Timepix3
Pixel pitch	55 μm
# of pixels	256 x 256
# of thresholds	1
Throughput	up to 80 Mhits/s for 10 Gb/s up to 15 Mhits/s for 1 Gb/s

Time resolution	1.6 ns
Effective frame rate	> 500 MHz
Pixel hit dead time	~1 µs
Read-out mode	Data driven,
	simultaneous time and
	intensity by per pixel
	ToA and ToT detection
Other	
Computer interface	1 Gb/10 Gb Ethernet
External shutter control	Yes
External signal	260 ps
time stamping	
Weight	2.2 kg
Dimensions (I x w x h)	28.5 x 80 x 90 cm ³
Cooling	Air
Acquisition software	GUI for Windows/
	Linux/Mac
Road out dood time	Dead time zero, within
Read-out dead time	allowed throughput

The technology can be used in multiple applications such as:

- Energy resolved X-ray
- Computed tomography
- Fast product-line X-ray inspection
- Electron microscopy
- Mass spectrometry
- Single photon imaging
- Ion and electron imaging



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